



Phase-Shifting Zernike Wavefront Sensor

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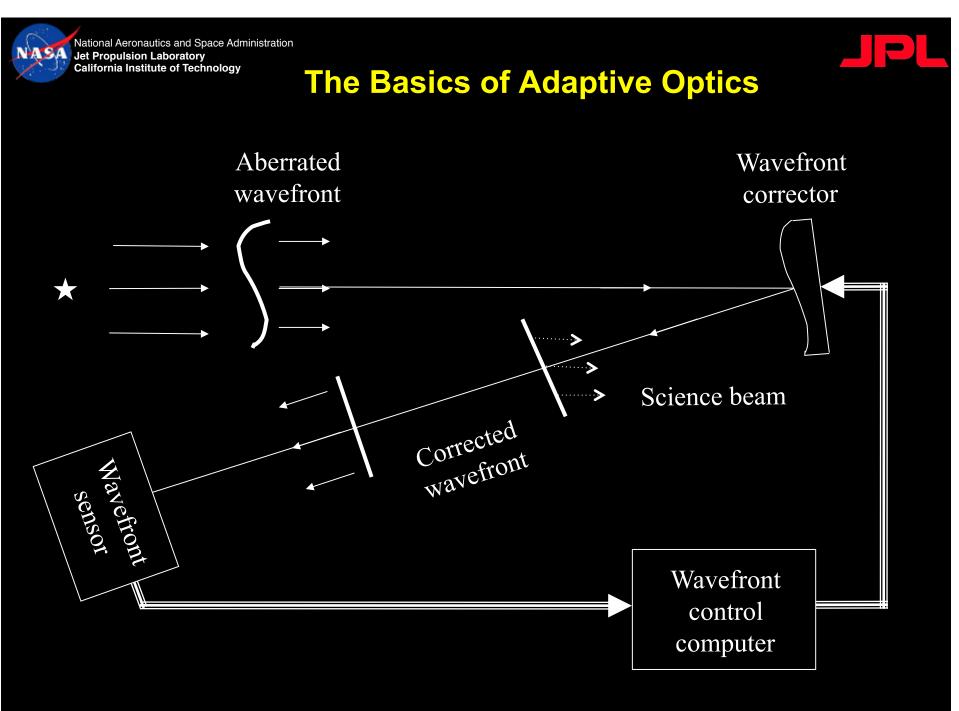
Supported by the JPL Research & Technology Development Fund





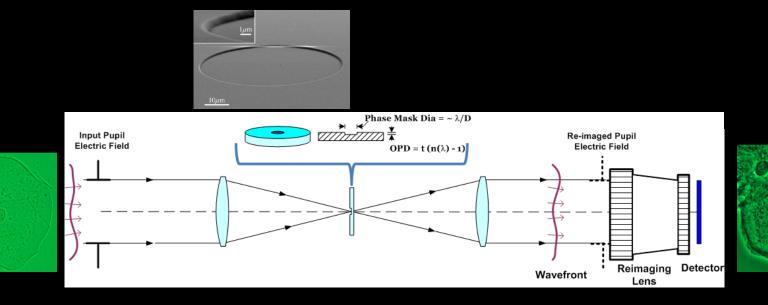
Overview

- 1. Background and theory
- 2. Testbed
- 3. Simulation
- 4. Telescope implementations





Transparent Specimens and Microscopy



- Properties of Classic Zernike Phase-contrast
 - Phase is converted to intensity
 - Very easy to implement, very robust
 - Limited dynamic range



Zernike Phase Reconstruction

Input Pupil	$E(u,v) = P(u,v) \cdot A(1 + \varepsilon(u,v))e^{i\varphi(u,v)}$ $\oint \Phi(u,v) << 1 \text{ rad}$ $E(u,v) \approx P(u,v) \cdot A(1 + \varepsilon(u,v) + i\varphi(u,v))$
Image Plane	$E(\eta, \upsilon) = APSF(\eta, \upsilon) + APSF(\eta, \upsilon) * F[\varepsilon(u, \upsilon) + i\varphi(u, \upsilon)]$ $\bigvee \qquad \qquad$
Output Pupil	$E(x,y) = AP(x,y) \cdot (e^{i\theta} + \varepsilon(x,y) + i\varphi(x,y))$ $\downarrow \qquad \qquad$



Static Zernike Phase Reconstruction

Apply a phase shift $e^{-i\pi/2}$ in the image plane

Propagate the electric field to the output pupil

$$E = A(e^{-i\pi/2} + \varepsilon + i\varphi) = A(-i + \varepsilon + i\varphi)$$

Convert to intensity

$$I = E \cdot E^* = A^2 (1 + \varepsilon^2 - 2\varphi + \varphi^2)$$

Dropping second order terms, intensity is now proportional to phase



Static Zernike Phase Reconstruction

Advantages

- **1.** Easy to interpret measurements
- 2. The sensor is common mode
- 3. Easy to control sampling

Disadvantages

- 1. Sensitive to <u>any</u> system error resulting in signal variation
- 2. Amplitude fluctuations cause spurious signals (e.g. atmosphere scintillation)



Dynamic Phase Reconstruction

Apply a series of phase shifts $e^{i\theta}$ in the image plane: $\Theta = -\pi/2, 0, \pi/2, \pi$

Propagate the electric field to the output pupil:

$$\begin{split} E_1 &= A(e^{-i\pi/2} + \varepsilon + i\varphi) = A(-i + \varepsilon + i\varphi) \\ E_2 &= A(e^{i0} + \varepsilon + i\varphi) = A(1 + \varepsilon + i\varphi) \\ E_3 &= A(e^{i\pi/2} + \varepsilon + i\varphi) = A(i + \varepsilon + i\varphi) \\ E_4 &= A(e^{-i\pi} + \varepsilon + i\varphi) = A(-1 + \varepsilon + i\varphi) \end{split}$$



Zernike Phase Contrast

Convert the output pupil electric fields to intensity

$$I_{1} = E_{1} \cdot E_{1}^{*} = A^{2}(1 + \varepsilon^{2} - 2\varphi + \varphi^{2})$$

$$I_{2} = E_{2} \cdot E_{2}^{*} = A^{2}(1 + \varepsilon^{2} + 2\varepsilon + \varphi^{2})$$

$$I_{3} = E_{3} \cdot E_{3}^{*} = A^{2}(1 + \varepsilon^{2} + 2\varphi + \varphi^{2})$$

$$I_{4} = E_{4} \cdot E_{4}^{*} = A^{2}(1 + \varepsilon^{2} - 2\varepsilon + \varphi^{2})$$

Solve for ϕ and ϵ

$$\varphi = \frac{I_3 - I_1}{4A^2}$$
 $\varepsilon = \frac{I_2 - I_4}{4A^2}$



Advantages of Dynamic Approach

• Like Classic Zernike, it is common mode

- Not affected by non-common path optics
- Insensitive to vibration, thermal drift

Optical system is reflective

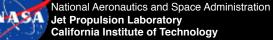
- Works with broadband white light
- Polarization insensitive

Phase shift is dynamic

- Synchronous-demodulation rejects noise sources not common with the phase-shifting frequency such as:
 - Detector noise
 - Stray light

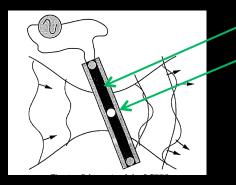
Reconstruction is mathematically simple

It can even be done on selective parts of the pupil





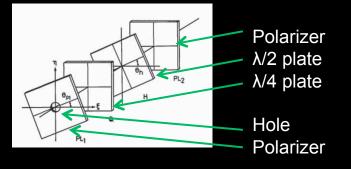
Phase Delay Techniques



Liquid crystal Glass bead

Liquid crystal point-diffraction **Mercer and Creath**

Applied Optics Vol. 35 No. 10 p. 1633 (1996)

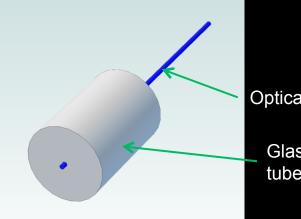


Polarization phase-shifting Kadono, Takai, and Asakura

Applied Optics Vol. 26, No. 5 p. 898 (1987)



Phase Delay Technique

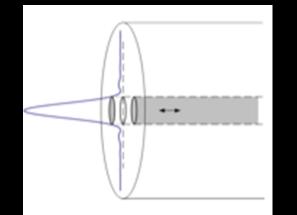


Capillary & fiber

Optical fiber

Glass capillary tube

Proc. SPIE 6888 68880B (2008)



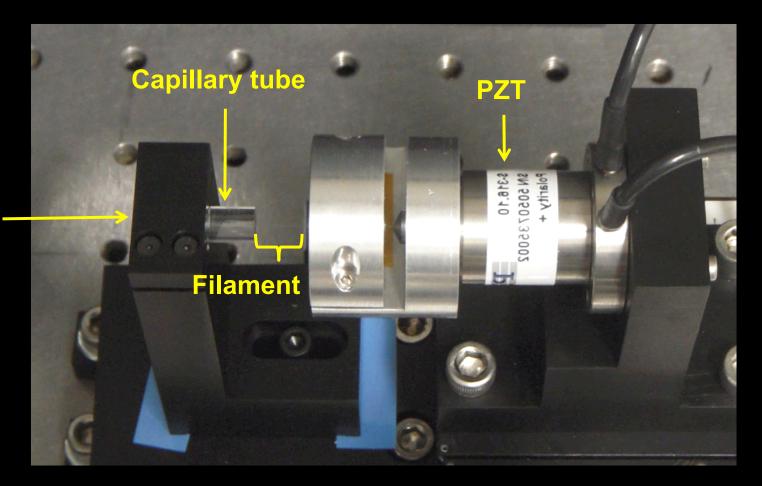
Cleaved fiber inside a polished glass capillary

- Both silver-coated
- Central core of PSF shifted by the fiber



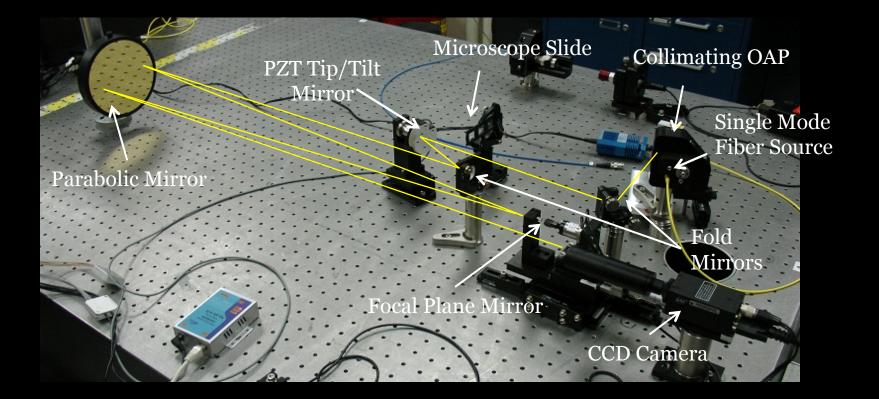
Phase Delay Implementation

Reflective surfaces of capillary/ fiber



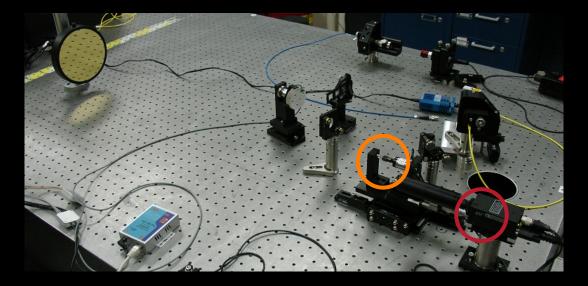


Dynamic Zernike Testbed



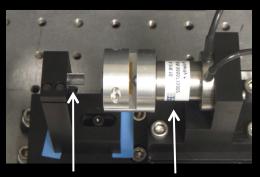


Dynamic Zernike Testbed



Focal Plane Assembly:

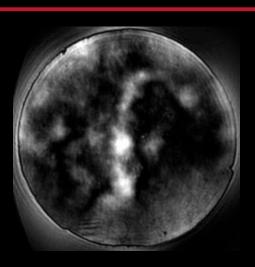
- Capillary tube
- Optical fiber
- PZT



PZT

Shifter

Capillary, fiber

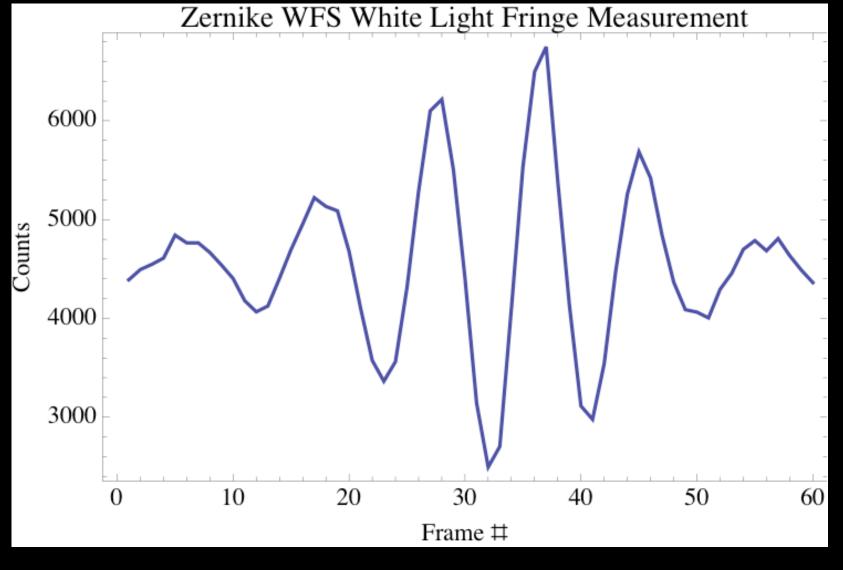


Output pupil Results:

- Pupil viewing CCD
- Intensity reflects microscope slide phase information

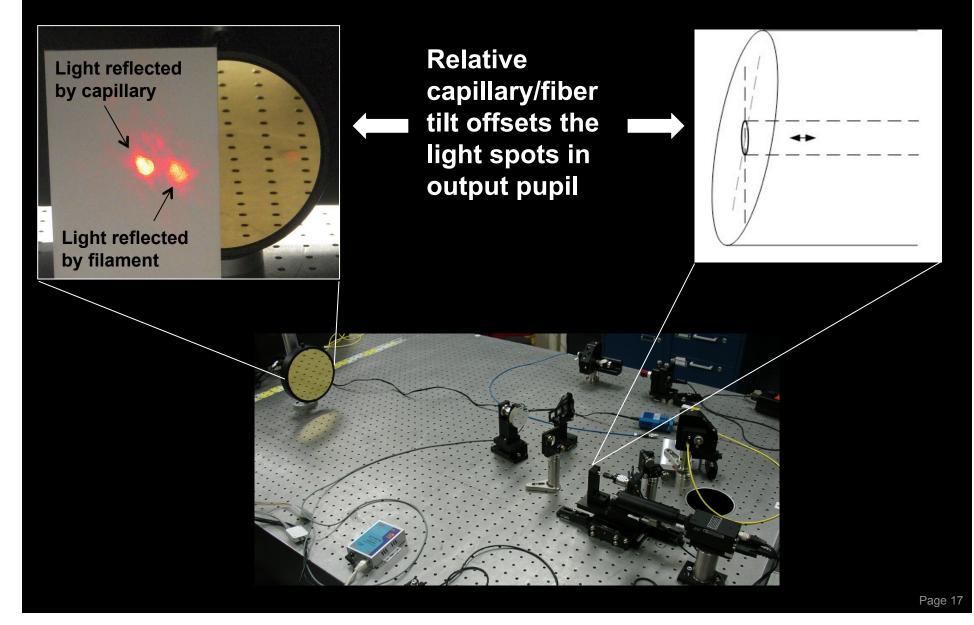


White Light Fringe





Mechanical Challenges



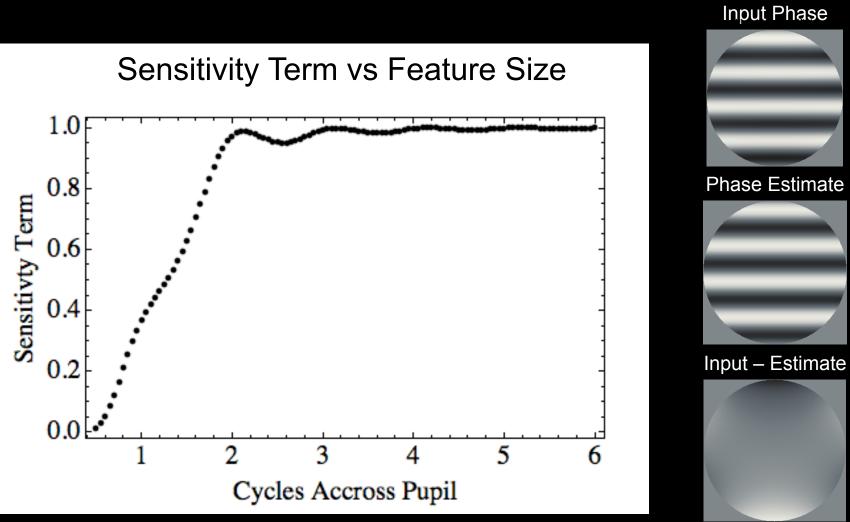


Fourier Mode Sensitivity

Input Phase Image Plane Intensity Phase Reconstruction **Residual Phase** Error



Fourier Mode Sensitivity



Amp=0.01λ RMS=0.002λ PV=0.003λ

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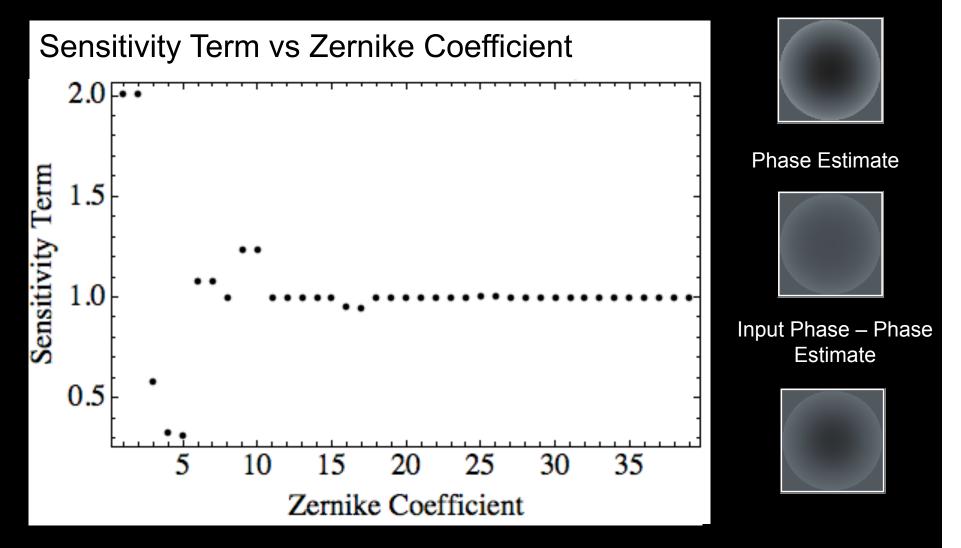
Zernike Mode Sensitivity

	Focus	Astigmatism	Coma	Spherical	Trefoil
	Z ₄	Z ₅	Z ₇	Z ₉	z ₁₀
Input Phase					
Image Plane Intensity					
Phase Reconstruction					
Residual Phase Error					



Zernike Mode Sensitivity



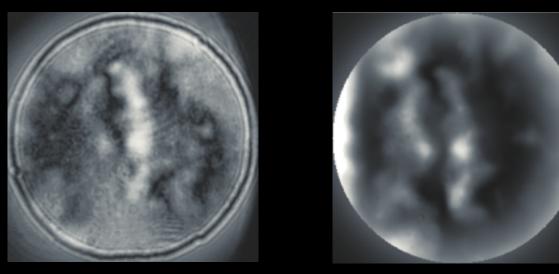




Simulation and Testbed Comparison

Testbed

Simulation



- The output pupil intensity reported by the testbed andsimulation share qualitative features
- Testbed focus and alignment will improve agreement

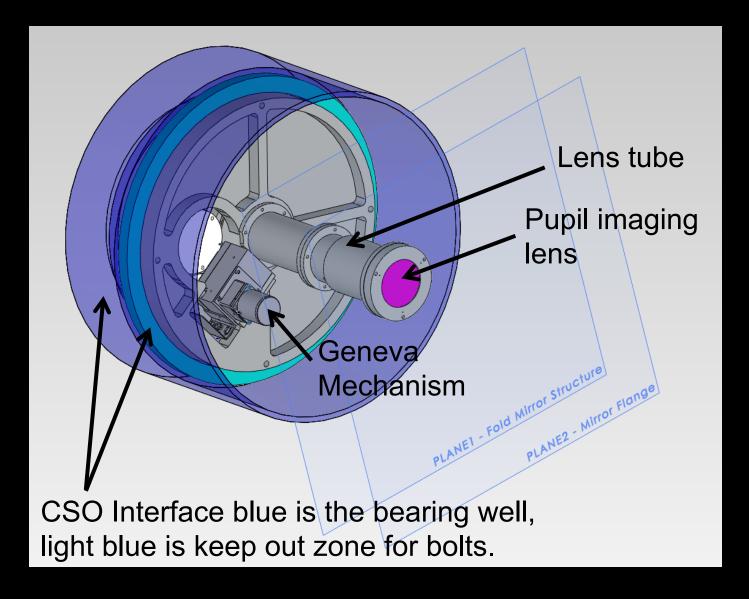


Caltech Submillimeter Observatory (CSO) Implementation

- Use ZWFS to measure a fraction of the CSO pupil
- Compare ZWFS with MGS on short time scales
- Acquire experience with ZWFS in preparation for CCAT phasing.

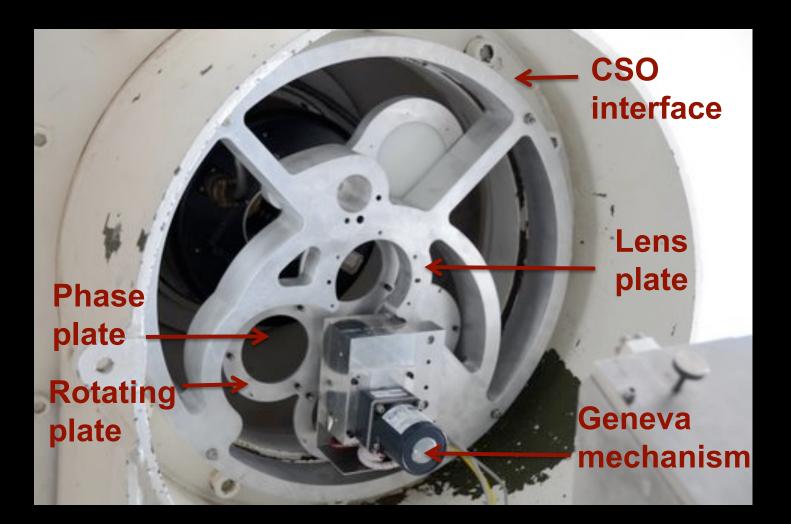


CSO Implementation



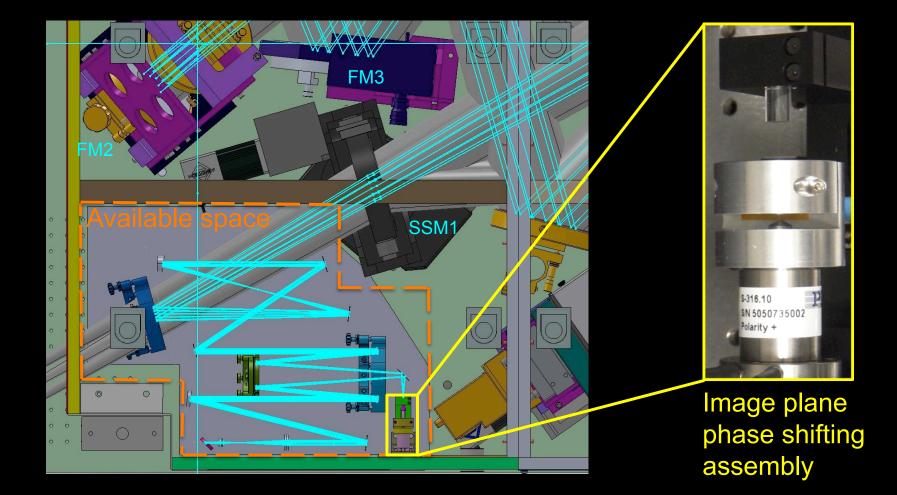


CSO Implementation





Mount Palomar Implementation





Conclusion

- Zernike phase contrast maps phase to intensity in the output pupil
- The Zernike wavefront sensor uses dynamic Zernike phase contrast to measure phase for telescope applications
- Future applications
 - Mount Palomar adaptive optics system
 - Phasing segmented mirrors (CCAT, space-based telescopes)



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